

**Notice of References Cited**

Application/Control No.

10/535,622

Applicant(s)/Patent Under  
Reexamination  
KNAPP ET AL.

Examiner

Nitin Parekh

Art Unit

2811

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,145,254	12-2006	Hirano et al.	257/796
*	B	US-2002/0151609	10-2002	Chaudhary et al.	521/60
*	C	US-6,958,535	10-2005	Hirano et al.	257/707
*	D	US-6,346,325	02-2002	Edwards et al.	428/401
*	E	US-2002/0151609	10-2002	Chaudhary et al.	521/60
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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